

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner		Art Unit		Page 1 of 4
HAI V. NGUYEN		2618		

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		Examiner HAI V. NGUYEN	Art Unit 2618	Page 2 of 4

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		10/582,490	WALLMARK ET AL.	
Examiner		Art Unit		Page 3 of 4
HAI V. NGUYEN		2618		

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Notice of References Cited		Application/Control No. 10/582,490	Applicant(s)/Patent Under Reexamination WALLMARK ET AL.	
		Examiner HAI V. NGUYEN	Art Unit 2618	Page 4 of 4

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